**Precision coating**

Many applications in the field of optics, electronics, sensors, energy and medical technology require highly precise coatings. Fraunhofer FEP develops deposition hardware and technologies for fabrication of those optically, electrically, acoustically and magnetically effective layers and layer systems. The pulse magnetron sputtering and magnetron PECVD processes are optimized concerning precision and long term stability as well as high deposition rate and uniformity even at large substrates. The combination of these processes with precise substrate movement and optical in-situ monitoring ensure reproducible coating properties and precise layer thicknesses.

**Reactive pulse magnetron sputtering (PMS) and magnetron PECVD**

With reactive PMS, it is possible to deposit compound layers with a high layer quality at high deposition rate. In this process, electrically conductive targets are sputtered while reactive gas (e.g. O₂, N₂, F₂, NH₃) or a mixture of them is introduced. The layer is formed out of the atomized target material and its reaction with the reactive gas on the substrate surface. The deposition rate is usually one magnitude higher than the one achieved by RF sputtering from the compound target.

In contrast, during the magnetron PECVD process, a precursor is introduced (e.g. SiH₄, HMDSO, TEOS).

**Dynamic/stationary coating**

During dynamic sputtering a substrate passes by the sputtering station. This procedure is usually preferred if large substrates or a large number of small substrates arranged on a carrier are to be coated in in-line deposition plants. The substrate remains in front of the sputtering station during stationary sputtering processes. This process is usually preferred for deposition of layers on single substrates (currently for substrates with a diameter up to 300 mm and for substrates with a diameter up to 450 mm in future) or on several small substrates arranged on a carrier in cluster deposition plants.

**New possibilities for demanding layer property portfolios**

Using pulsed powering the appropriate setting of pulse mode (unipolar, bipolar, pulse package) and pulse parameters (frequency, duty cycle) allows controlling energy input into the growing layers. Thus, previously unachievable layer properties and property combinations may be set simultaneously with high coating rates. System integrated controlling of process parameters (pressure, reactive gas flow and magnetic field strength) over target lifetime ensure long term stability and reproducibility of the plasma conditions and thus of the layer properties.
Application examples

**Optical interference coatings**
- optical filters for laser optics, spectroscopy applications
- anti-reflex layers on lenses for glasses
- SiO₂, Si₃N₄, Ta₂O₅, TiO₂, Al₂O₃, HfO₂, Nb₂O₅
- low thermal load on the substrate
- good adhesion and durability even on plastic substrates
- very low absorption and scattering losses
- deposition rates 1 ... 4 nm/s

**Piezo-electric layers**
- crystalline AlN and AlScN layers with high c-axis orientation
- deposition rates: 2 ... 4 nm/s
- piezoelectric coefficients up to $d_{33} = 30 \text{ pm/V}$
- Al₂O₃, SiO₂, Si₃N₄
  - as thin-film insulation with very good insulating properties
  - high deposition rate: 2 ... 4 nm/s
  - effective deposition of thick insulation layers with electric strength of up to 1500 V
  - on flat and 3-dimensional substrates

**Electrical insulation layers**
- for sensors (also component-integrated)
- for microelectronics
- for photovoltaics
- Al₂O₃, SiO₂, Si₃N₄ as thin-film insulation with very good insulating properties
- high deposition rate: 2 ... 4 nm/s
- effective deposition of thick insulation layers with electric strength of up to 1500 V
- on flat and 3-dimensional substrates

Layer type | Examples | Deposition rate [nm/s]
--- | --- | ---
metals | Al, Cr, Cu, ... | 15 ... 25
alloys | Ni/Al, Ni/V, CoNiCr... | 10 ... 15
binary compounds | Al₂O₃, AlN, AlF₃, SiO₂, Si₃N₄, TiO₂, Ta₂O₅, Nb₂O₅, TaN, HfO₂, ... | 2 ... 4
ternary compounds | Si₂O₃N₄, Al₂O₃N₄, Si₃Ta₂O₅, Al₂Sc,N₄ | 2 ... 4
gradient-coating systems | SiO₂ → SiₓOₓNₓ → Si₃N₄ | 2 ... 4
Al₂O₃ → AlₓOₓNₓ → AlN | 2 ... 4
Si₂O₃ → SiₓTa₂O₅ → Ta₂O₅ | 2 ... 4
hybrid compounds | SiₓCₓOₓHₓ, SiₓCₓOₓNₓHₓ, SiₓTiₓCₓOₓHₓ | 5 ... 15

SEM image of a Si₅Ta₂O₅ gradient-coating system (rugate design)

SEM image of an AlN layer with strong c-axis orientation

Pressure sensors with electrical insulation layers

Pressure sensors: © SIEGERT TFT GmbH
Passivation, protection and barrier layers
- for sensors
- for electronic components

- \( \text{Al}_2\text{O}_3, \text{SiO}_2, \text{Si}_3\text{N}_4 \)
  - as diffusion barriers for sensor elements, for photovoltaics and for organic electronics
  - as an etching-stop layer
  - as a passivation layer

SiO\(_2\) as a passivation layer for thin-film resistors

Titanium-dioxide layers
- photocatalytic, antibacterial
- photo-induced superhydrophilic
- for gas and moisture sensors

- hardness may be adjusted from 7 ... 14 GPa
- refractive index (VIS):
  \[ n = 2.4 \ldots 2.7 \text{ adjustable} \]
- structure: amorphous, crystalline (anatase, rutile)
- superhydrophilic after 30 minutes of UV-A irradiation (1 mW/cm\(^2\))

Superhydrophilic titanium-dioxide layer (right)

Functional layers
- for surface-wave components
- for electronic and MEMS components

- \( \text{SiO}_2\) layers for improved temperature stability in SAW components
- TaN layers for thin-film resistors

Surface-acoustic-wave (SAW) components

Integrated package with double ring magnetron (DRM) (schematic)

- magnet system control
- process management computer
  - power control
  - gas control
    - Ar
    - O\(_2\)
    - N\(_2\)

MF pulse powering

DRM – Sputter source
Integrated hardware packages

Fraunhofer FEP develops key components for reactive pulse magnetron sputtering. Together with the processes and technologies adapted for coating, these key components (integrated packages) can extend the capabilities of new and existing coating systems.

Sputtering sources
- rectangular magnetron (RM), up to 2 m, for dynamic coating
- multiple ring magnetron (MRM) sources for stationary coating
  - homogeneous layers regarding thickness and layer properties currently up to 200 mm diameter, in future up to 450 mm
  - separately controllable concentric plasma discharges, two or three rings, possible
  - adaptation of layer thickness distribution to curved surfaces

Process-control units
The PCUplus and S-PCU devices are used to control reactive sputtering processes. They enable new freedom degrees with regard to control of layer properties by adjustment of pulse mode and pulse parameters.

Pulse power supplies
Two types of pulse-power supplies – UBS-C2 and i-PULSE® – have been developed for different applications and performance ranges (up to 60 kW). They enable new freedom degrees with regard to control of layer properties by adjustment of pulse mode and pulse parameters.

Our offer
- development and optimization of coating technologies, reactive sputtering processes and coating systems for your applications
- coating of samples and pilot production
- development of key components such as magnetron sputter sources, plasma-etching sources, process-control units adapted to the requirements of the coating tasks
- transfer of integrated packages, consisting of key components, fully automatic process and control systems as well as technology, into production plants
- assistance with cost estimation and technical implementation into deposition plants

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